

**Search Notes**

Application/Control No.

10/711,022

Examiner

Amy R. Cohen

**Applicant(s)/Patent under Reexamination**

CHANG ET AL.

Art Unit

2859

**SEARCHED**

Class	Subclass	Date	Examiner
33	645 613 562	11/5/2006	ARC
	563 566		
	567 567.1		
	644 533		
	662 507		
	526 527		
	520 Dig. 10		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class 33, Cohen	11/5/2006	ARC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner